Notice of References Cited Application/Control No. 09/881,912 Examiner David E. England Applicant(s)/Patent Under Reexamination NISHIKAWA ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,640,239 B1	10-2003	Gidwani, Sanjay M.	709/203
	В	US-6,559,882 B1	05-2003	Kerchner, Lynn L.	348/61
	С	US-2002/0147850 A1	10-2002	Richards et al.	709/248
	D	US-2002/0107955 A1	08-2002	Rawson, Freeman Leigh III	709/224
	E	US-6,167,120	12-2000	Kikinis, Dan	379/90.01
	F	US-6,188,397 B1	02-2001	Humpleman, Richard	725/80
	G	US-5,898,831 A	04-1999	Hall et al.	713/201
	Н	US-6,535,927 B1	03-2003	Kim, Hoon-Jae	709/249
	ı	US-6,751,218 B1	06-2004	Hagirahim et al.	370/390
	J	US-6,430,624 B1	08-2002	Jamtgaard et al.	709/246
	К	US-2002/0069296 A1	06-2002	Aua et al.	709/246
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.